

The barrel ladder tests

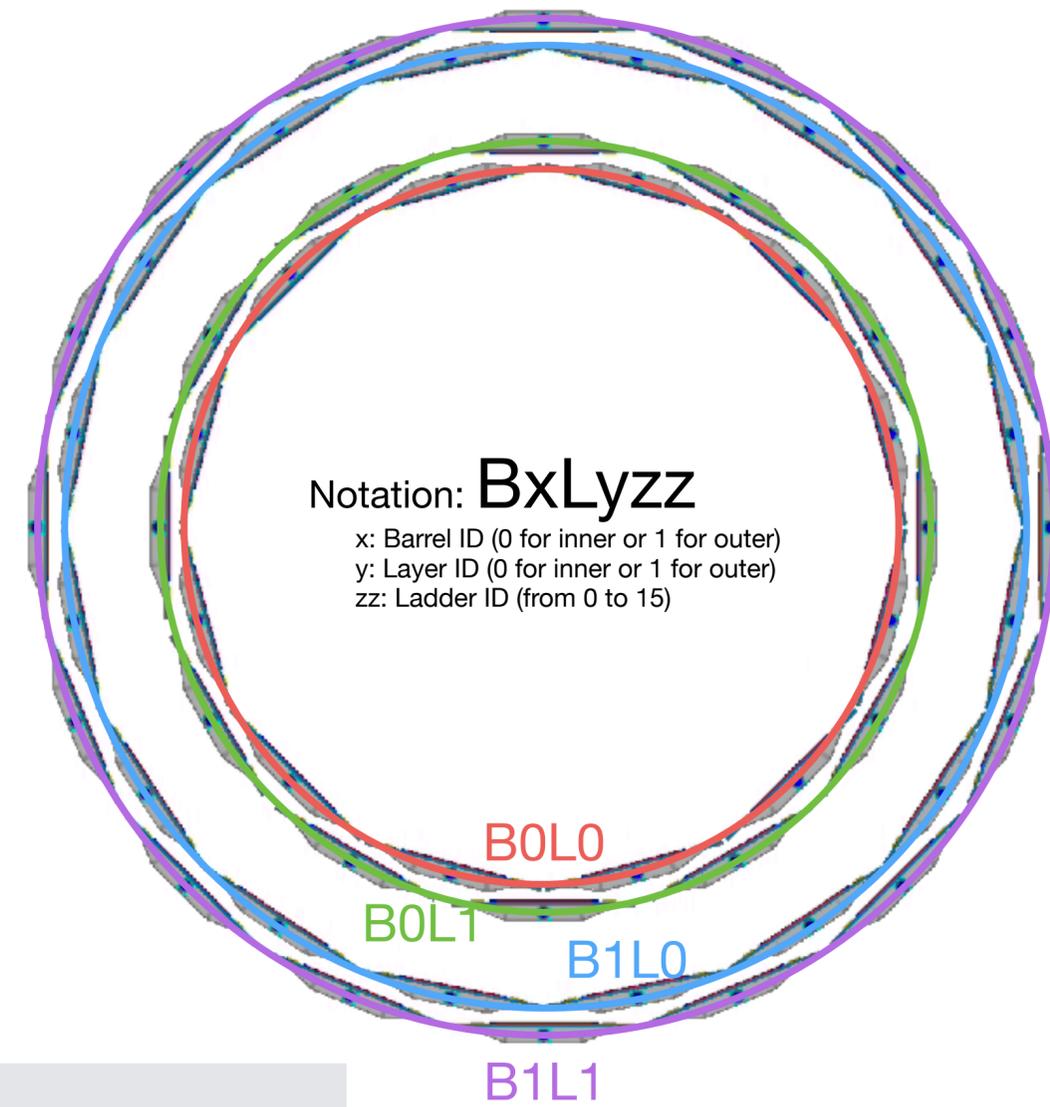
G. Nukazuka (RBRC),

R. Nouicer(BNL), R. Pisani(BNL),

M. Hata(NWU), M. Watanabe(NWU),

W. Tang(NCU)

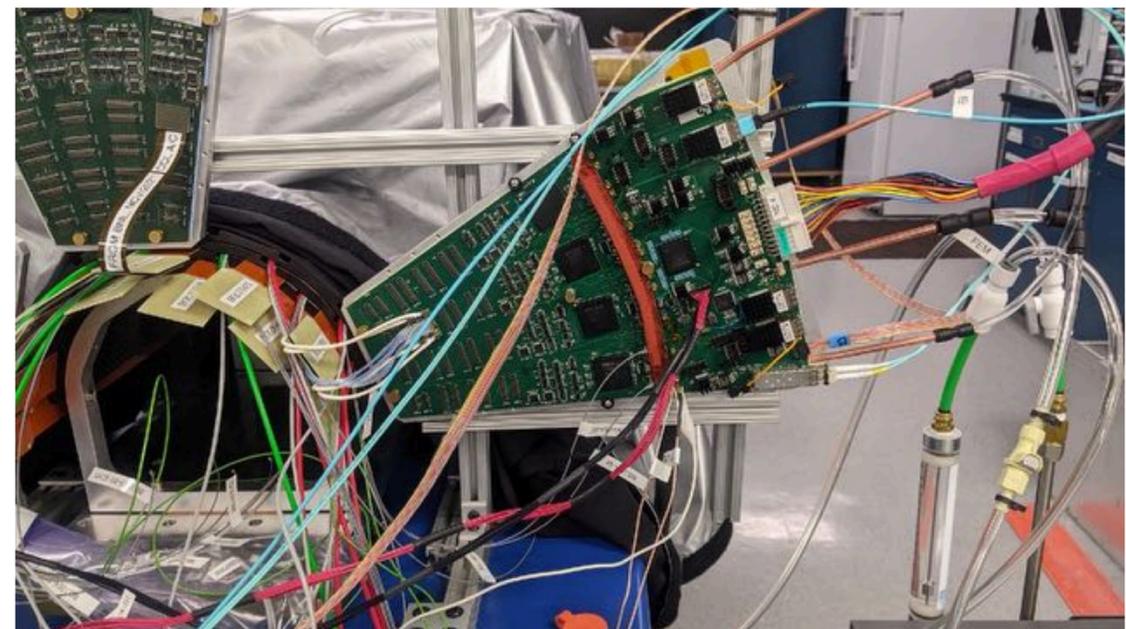
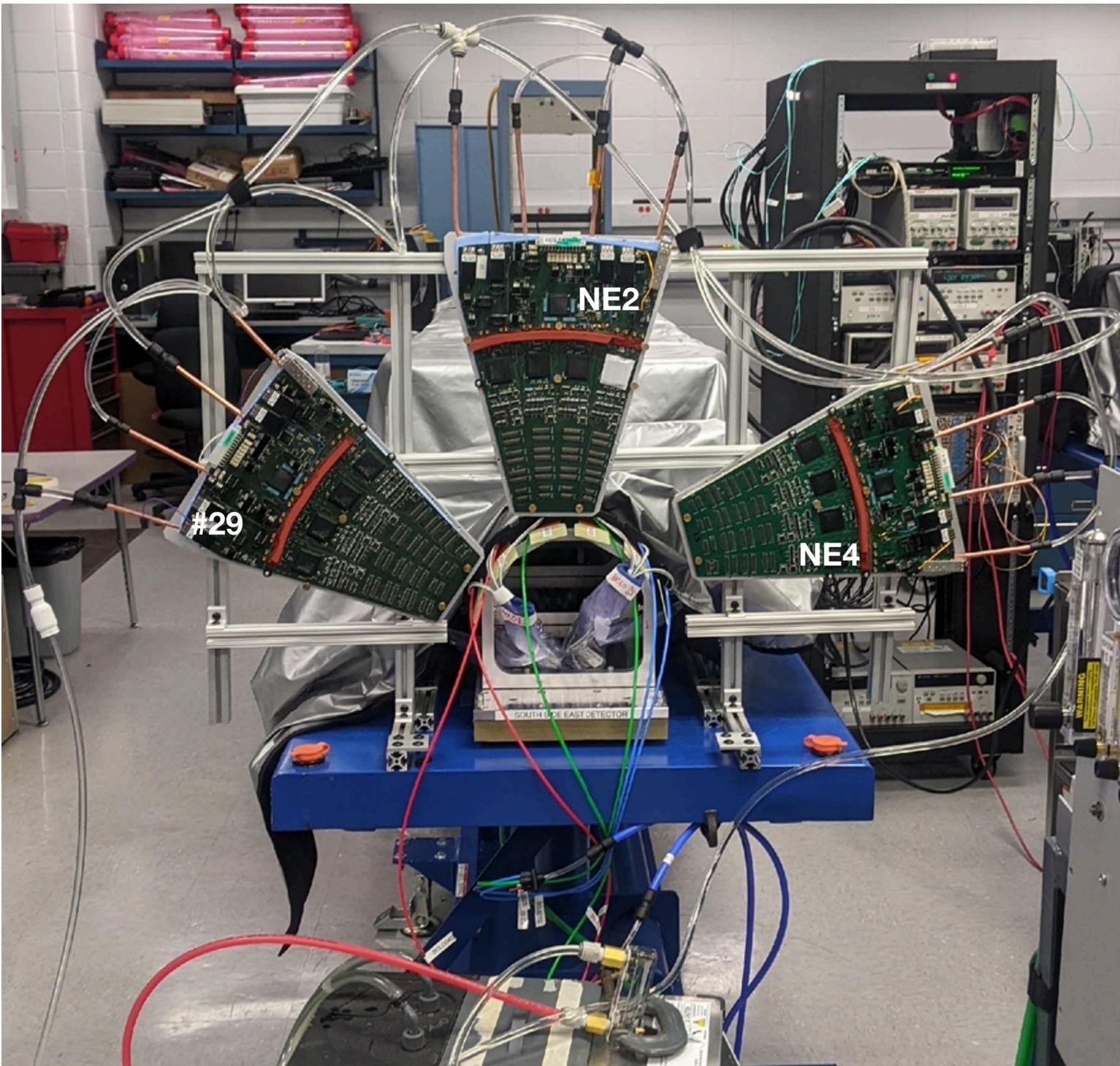
Tests of the barrel ladders



	Date	Tested layers	Results
1st test	June/10- June/14	B0L0	Good.
2nd test	June/17- July/07	B0L1, some of B0L0	Some ladders in B0L1 were noisy. GND condition was investigated.
3rd test	Aug/10- now	B1L0 (some of) B0L1&B0L0	Ongoing Tested ladders showed good results.
4th test	later...		

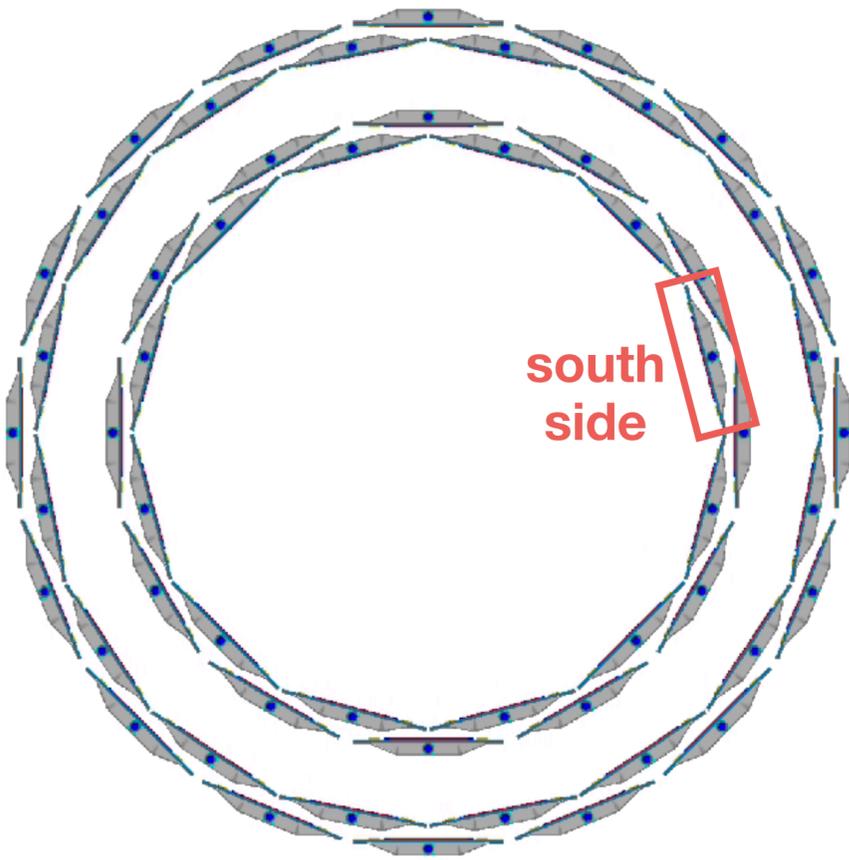
The barrel calibration tests: The setup

- 3 good ROCs (NE2, NE4, and #29)
 - 3 ROCs were put on each side in the 3rd test
- The FEM/FEM-IB system
- The same LV system as the test bench
 - upgraded in the 3rd test
- The new temperature monitor system
- The ladder cooling and the ROC cooling
- The FPC conversion cable or the μ -coaxial conversion cable was used. No difference found b/w the 2 types.
- A single ladder was operated to test it.

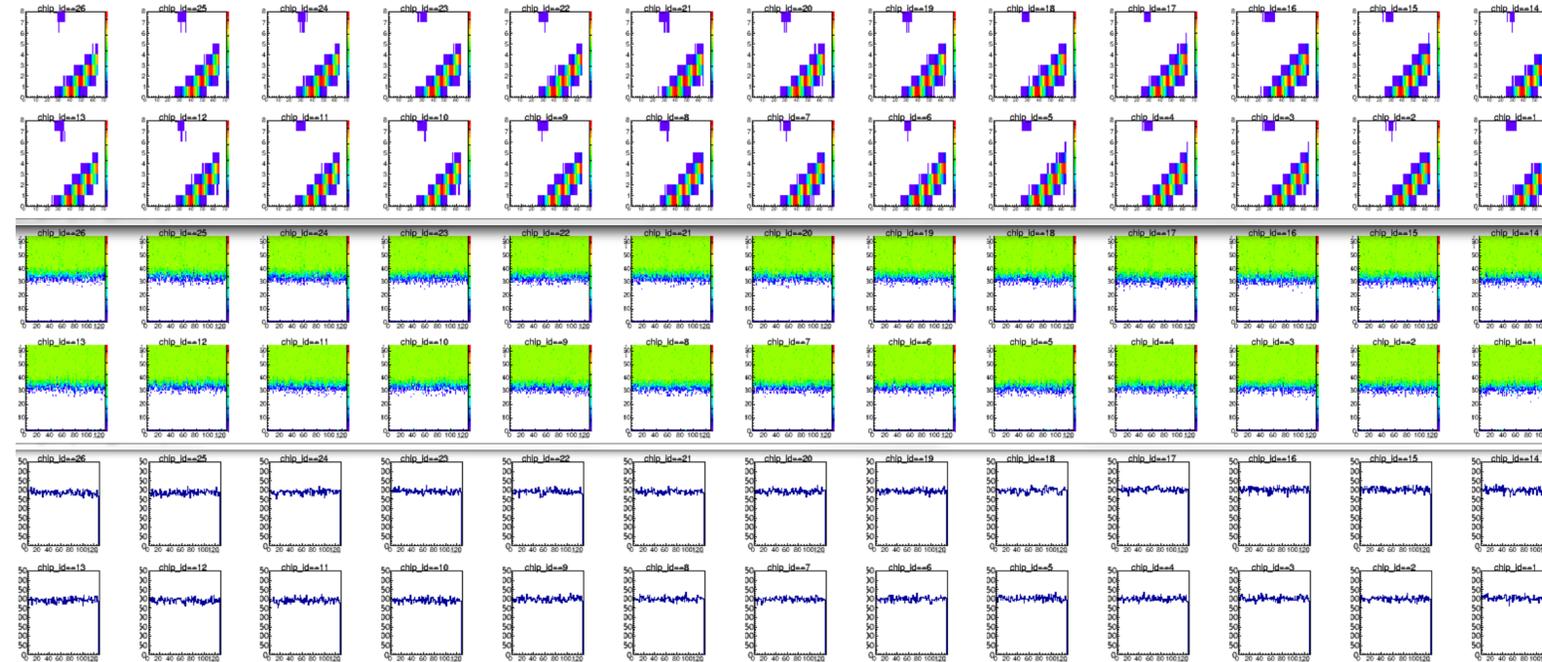


Results: A typical good case (the 1st&2nd tests)

BOL002S (PB1-L031)



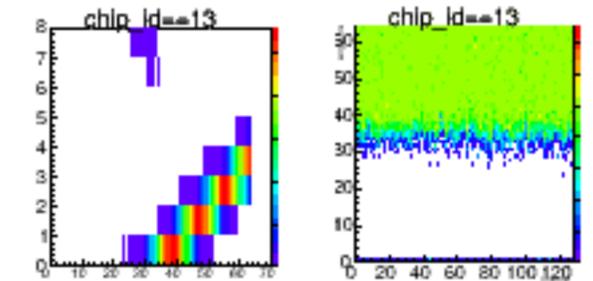
Test bench



Data: 20220513_1217, 111 cm Bus extender + 20 cm FPC conversion cable

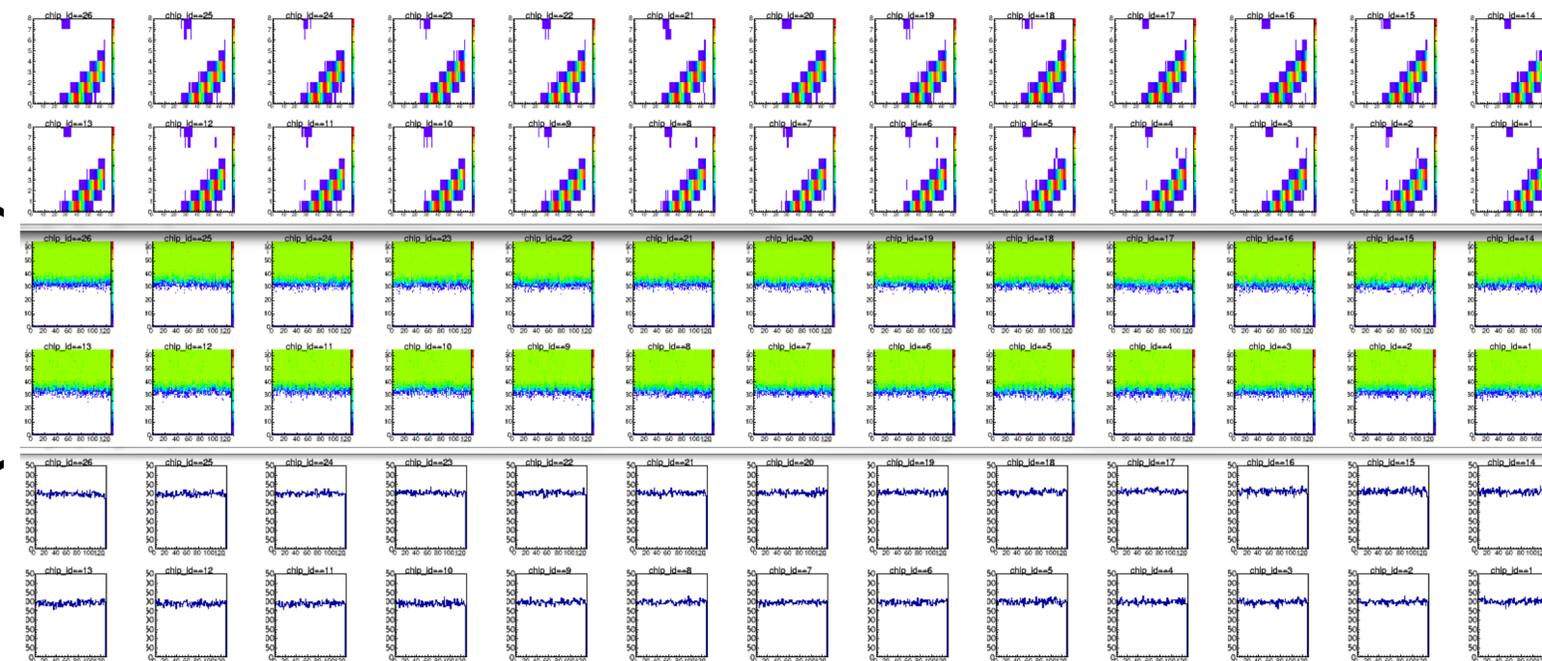
Bias current
type-A: 184 nA
type-B: 141 nA

Chip13



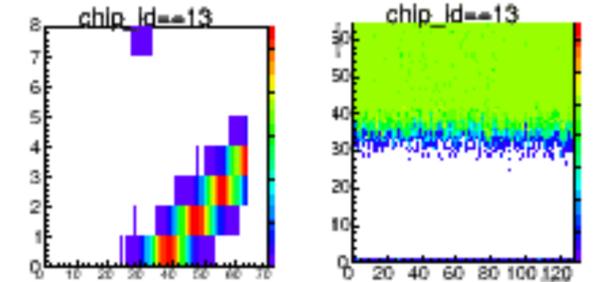
Generally speaking, many ladders showed results as good as ones in the test bench

Barrel
(1st test)



Data: 20220613_1546

Chip13



Bias current
type-A: 135 nA
type-B: 102 nA

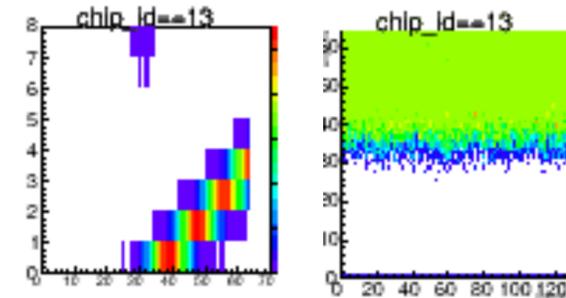
Results: A typical difficult case (the 2nd test)

B0L103N (PB1-L0??)

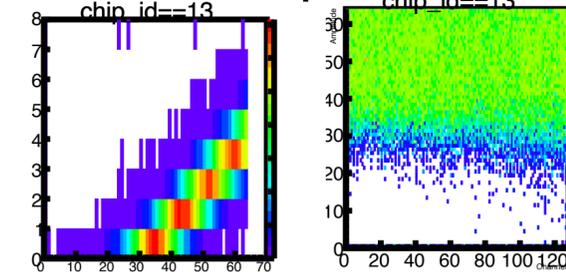
Due to the radiation source ↓

Bias current
type-A: 139 nA
type-B: 98 nA

Chip13

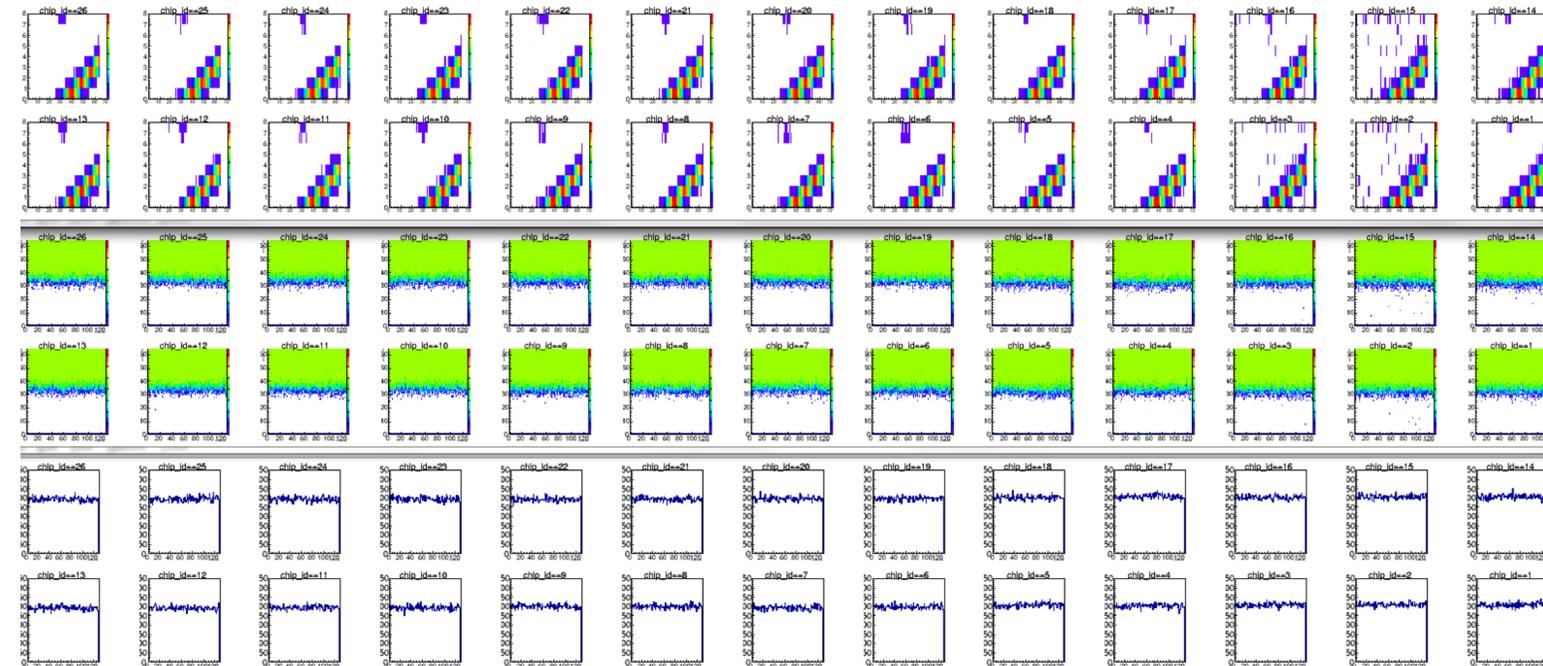


Chip13



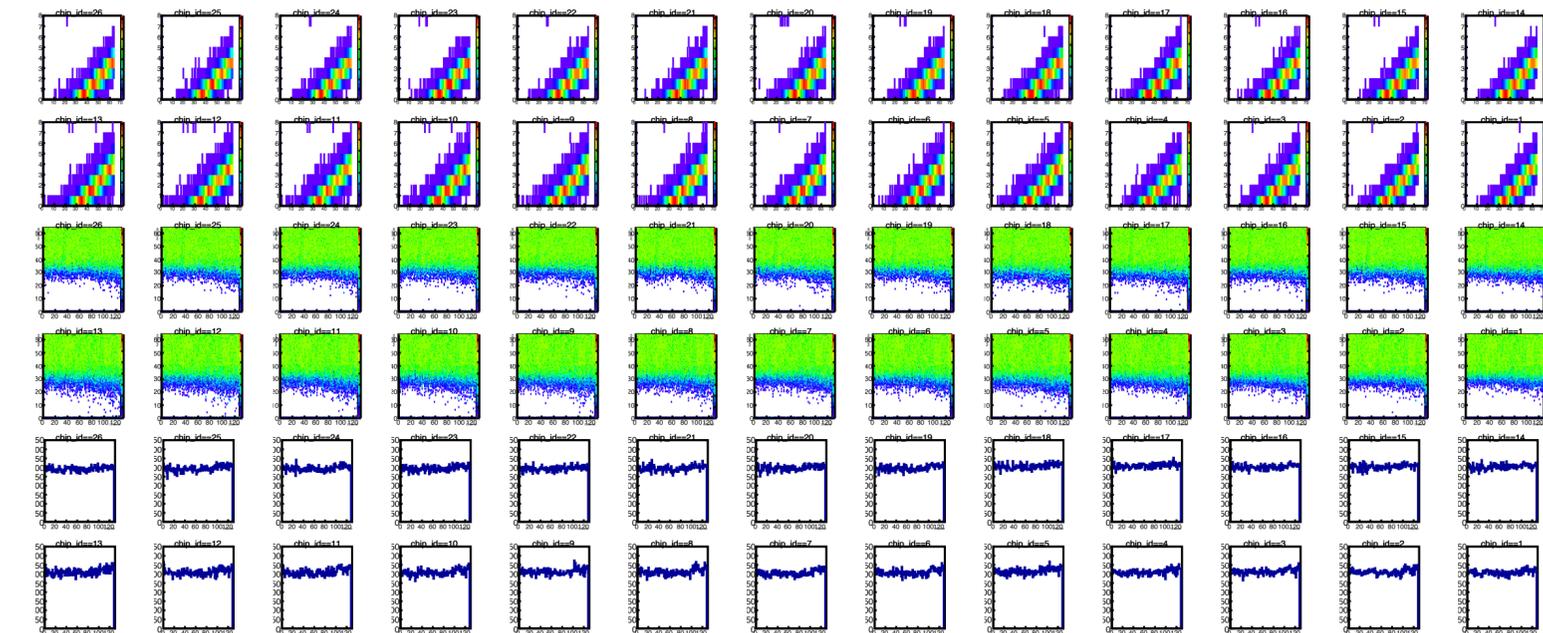
Bias current
type-A: 117 nA
type-B: 83 nA

Test bench

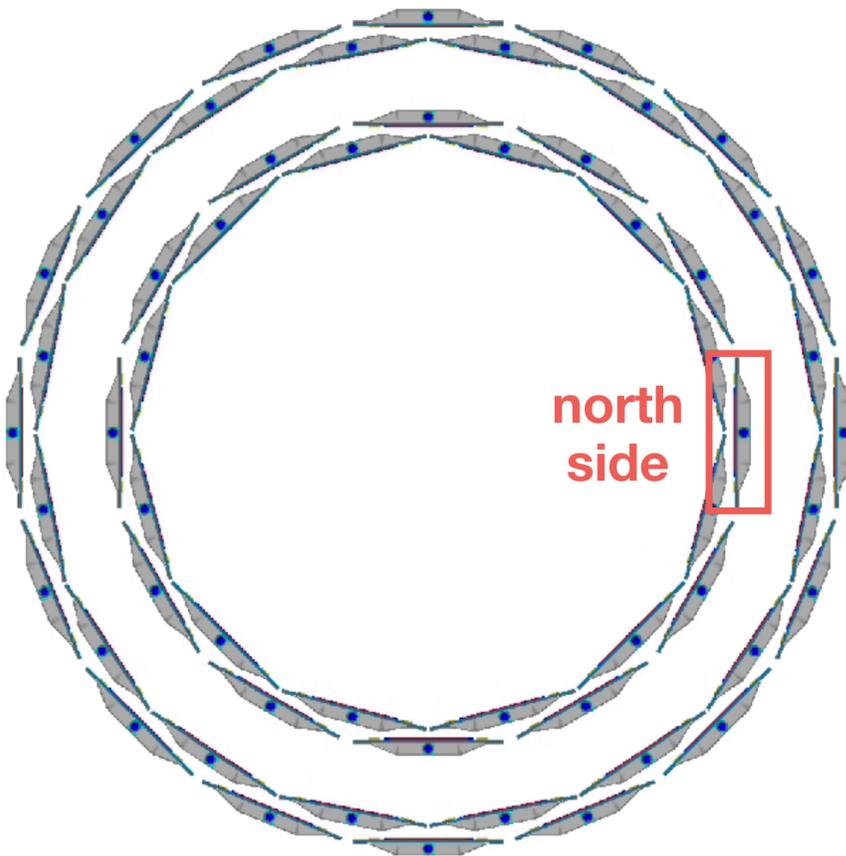


Data: 20220420_1927

Barrel



Data: 20220622_1248 (after modification of GND, good results were obtained)



Results in the barrel had more noise than those in the test bench on some B0L1 ladders.

GND investigations in the 2nd test



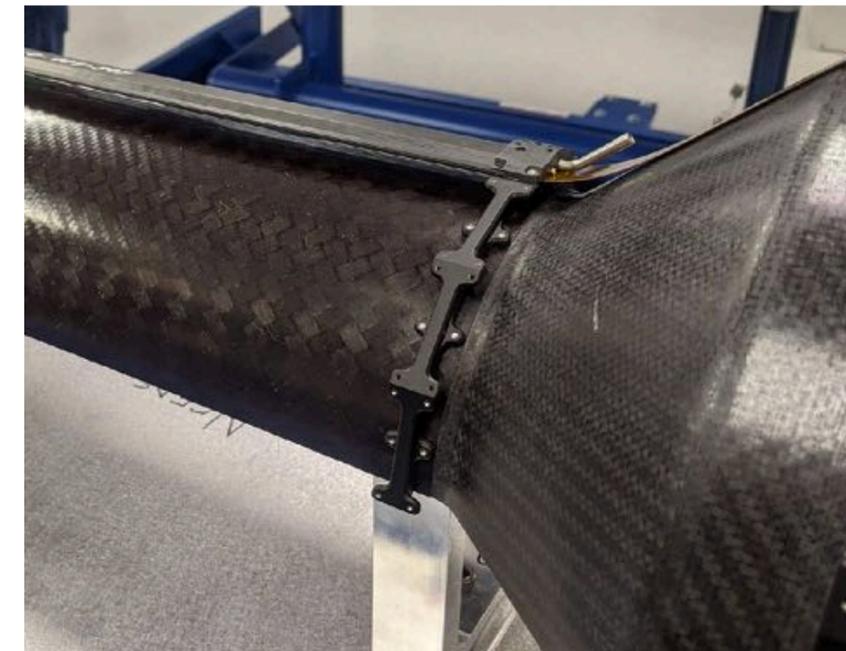
to the power supplies

ROC power supply cables

to the bias power supply

Bias cables

Conversion cable



B0L1 (East)

HDI

Bus extender

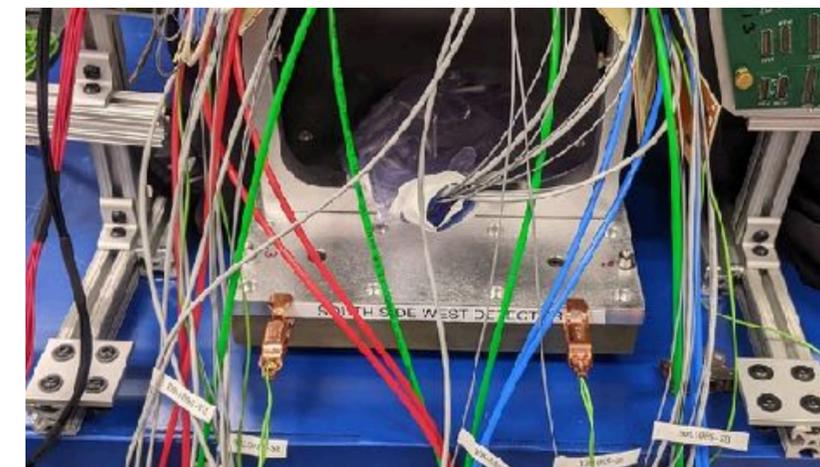
Stave GND cables

B0L0 (East)

Stave GND cables

Stave GND cables

Aluminum supporting structure



Without the stave GNDs connection to the aluminum supporting structure,

B0L0 \leftrightarrow the supporting structure: $\sim 0 \Omega$

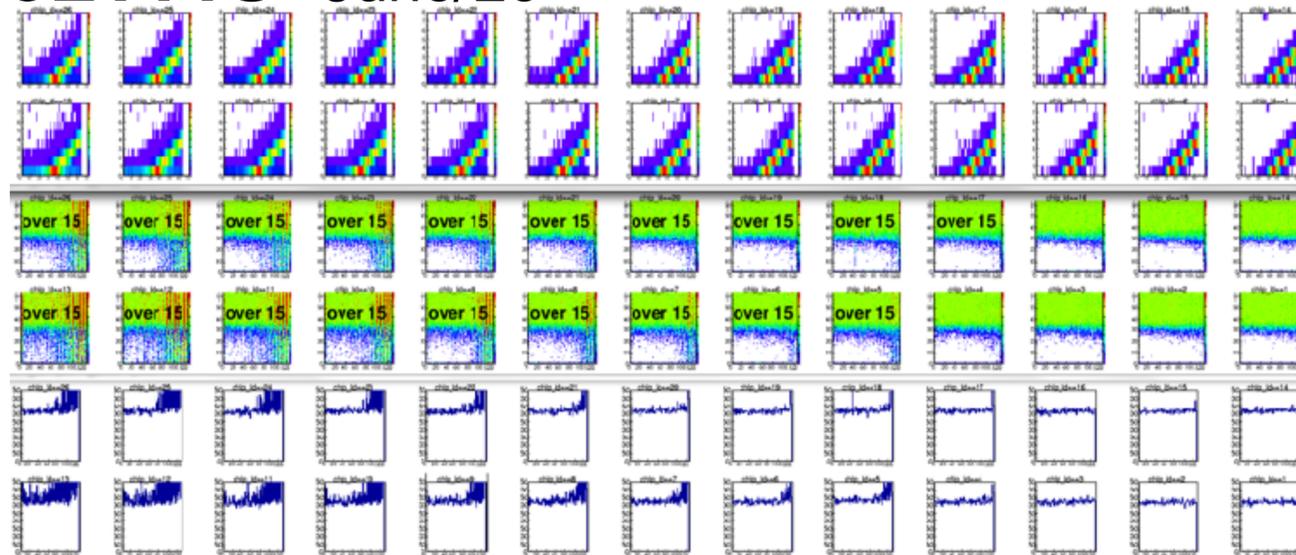
B0L1 \leftrightarrow the supporting structure: 180Ω

Note: CFC cone omitted

GND investigations: The harvest

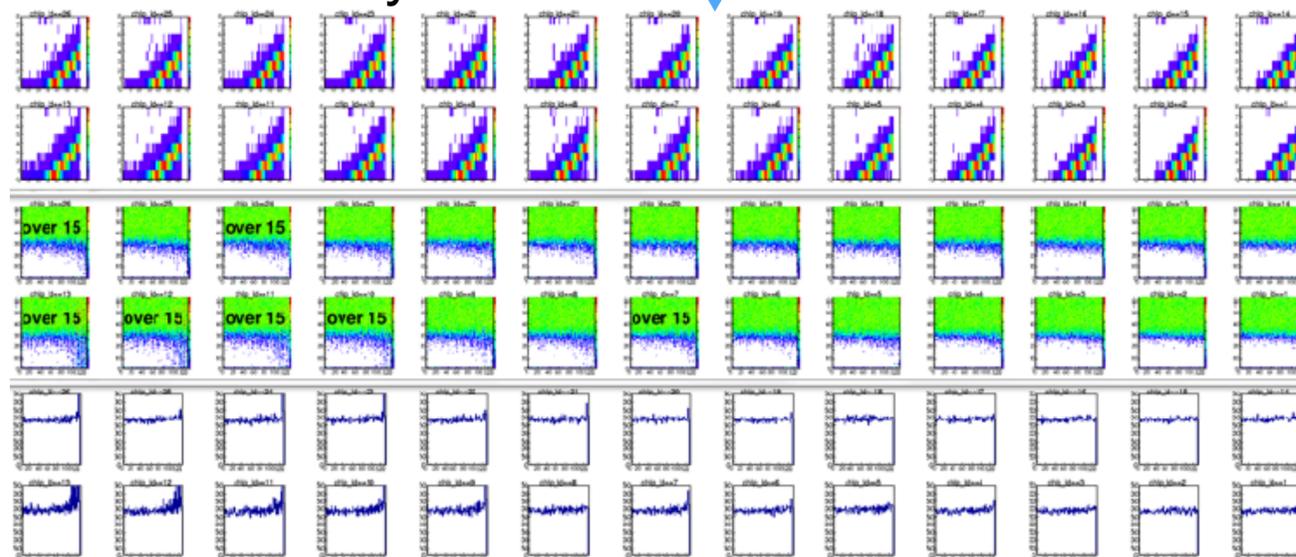
Connecting the stave GNDs to the aluminum supporting structure drastically improves the condition.

BOL111S June/29



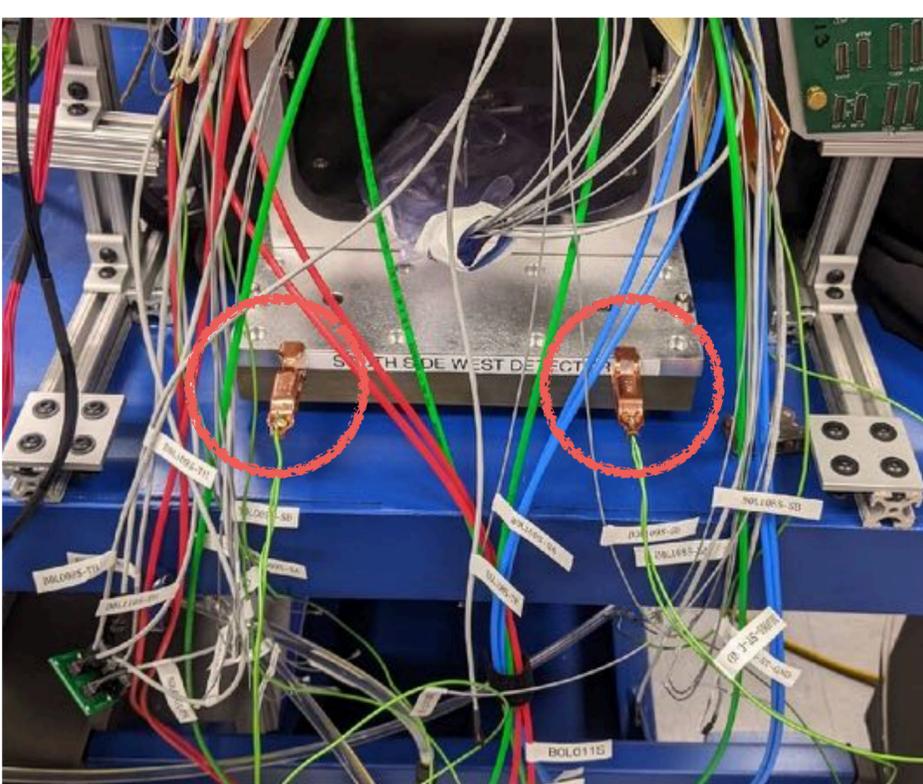
BOL0 ↔ the supporting structure: $\sim 0 \Omega$
BOL1 ↔ the supporting structure: 180Ω

July/07

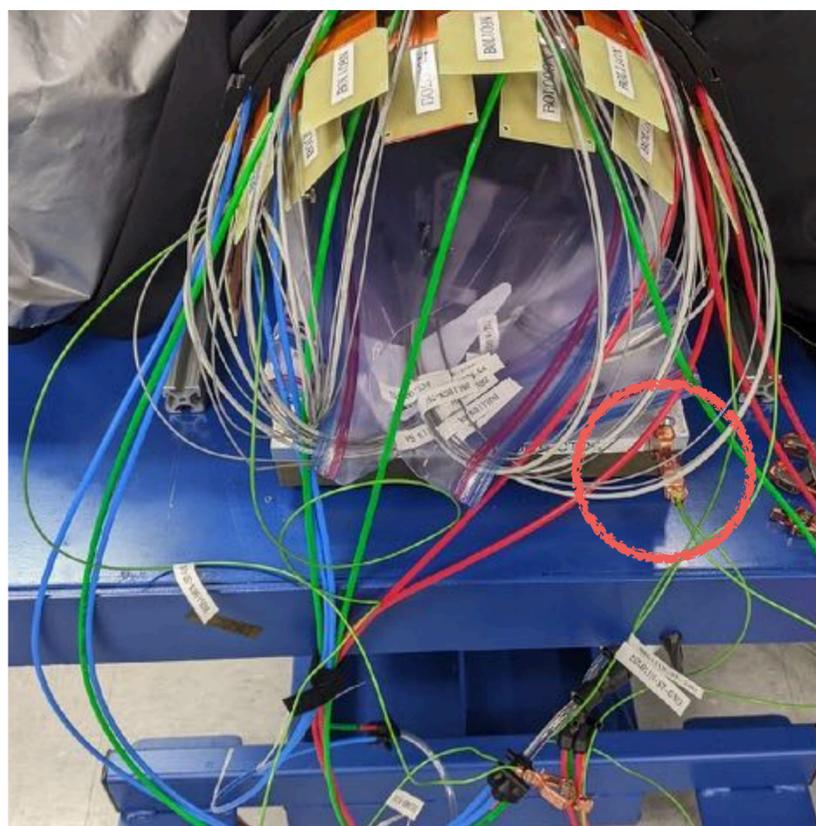


BOL0 ↔ the supporting structure: $\sim 0 \Omega$
BOL1 ↔ the supporting structure: $\sim 0 \Omega$

All staves must be well connected to GND. In the IR, there is a GND port for this purpose. In the silicon lab, the aluminum supporting plate on the table can be large enough GND port. Power supplies with less noise are also necessary.



South side



North side

Upgrades on HV&LV

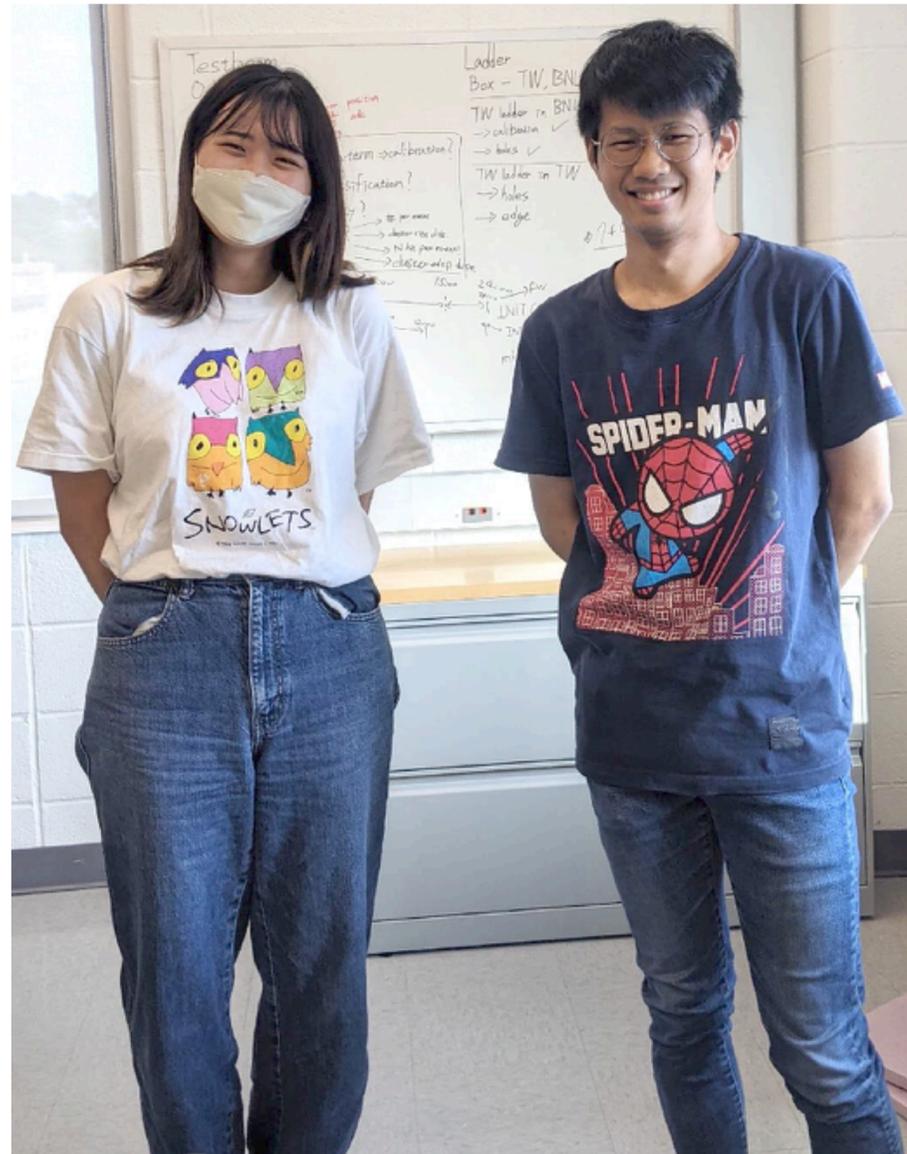
HV & LV power supplies were upgraded to the same one used in IR, so the environment is much cleaner now.

Thanks to Maki&Wei-Che, the new power supply system is operational.

See their reports for more details:

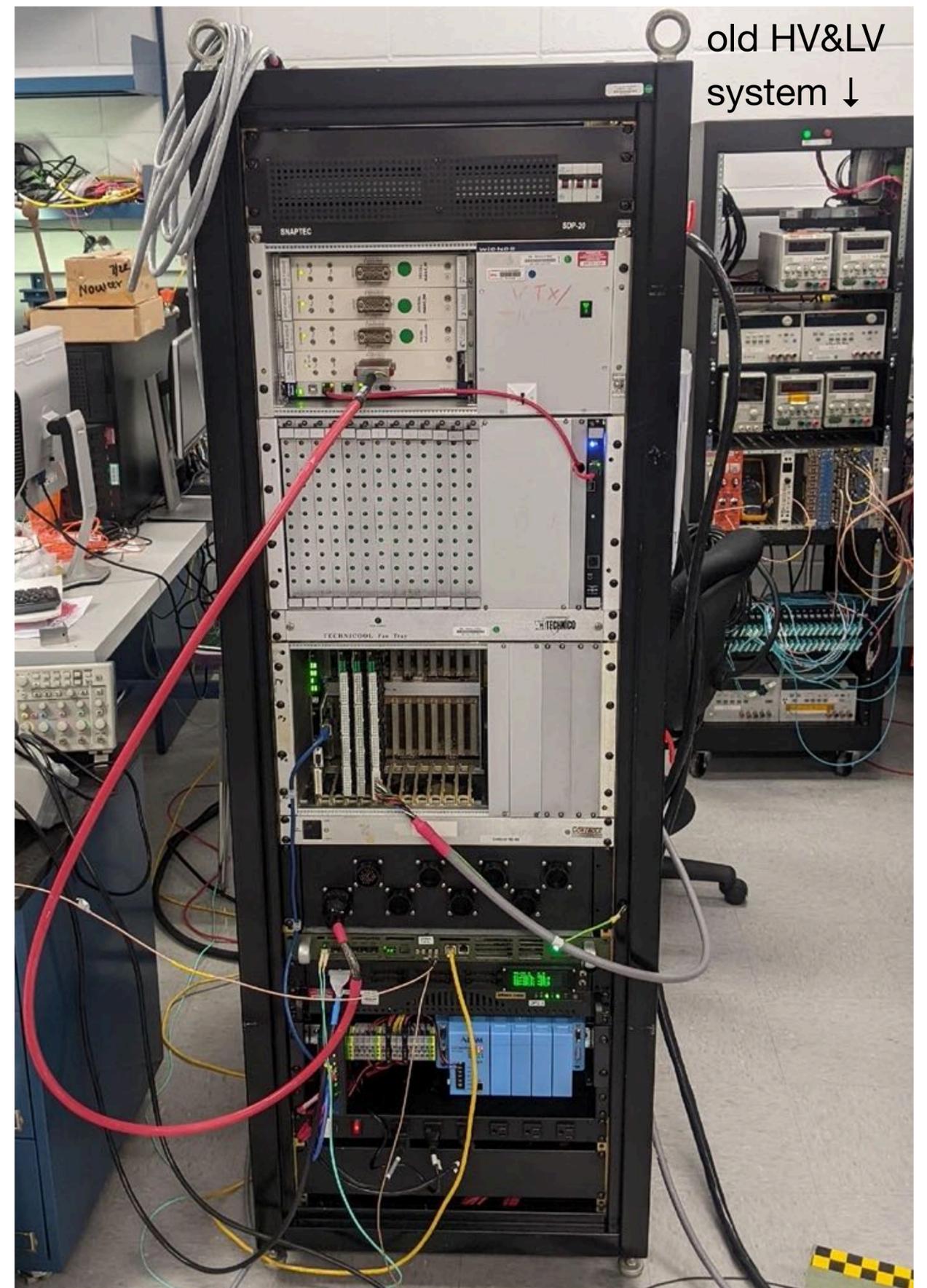
- [HV by Maki](#)
- [LV by Wei-Che](#)

The 3rd test was started on Aug/10.



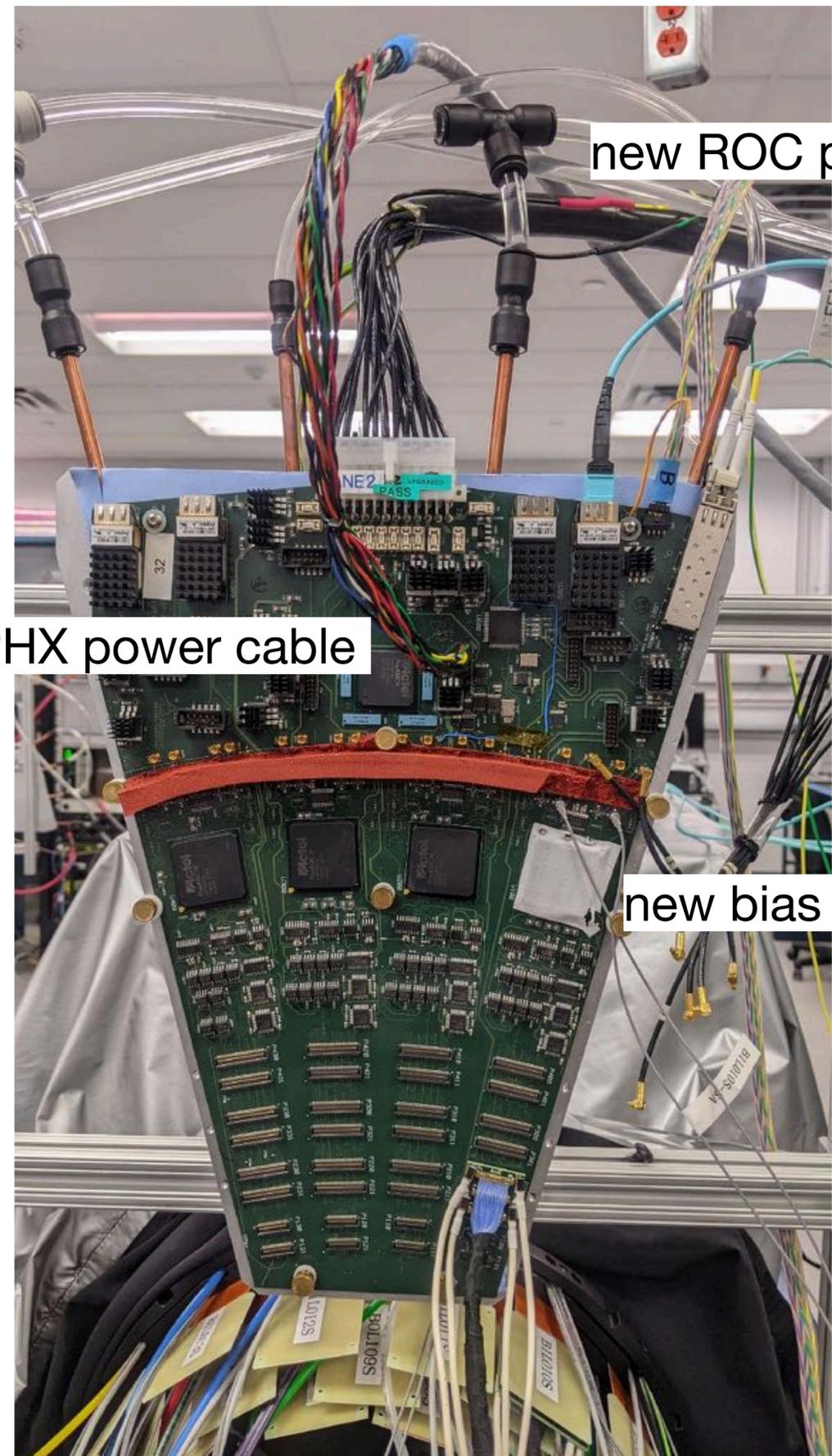
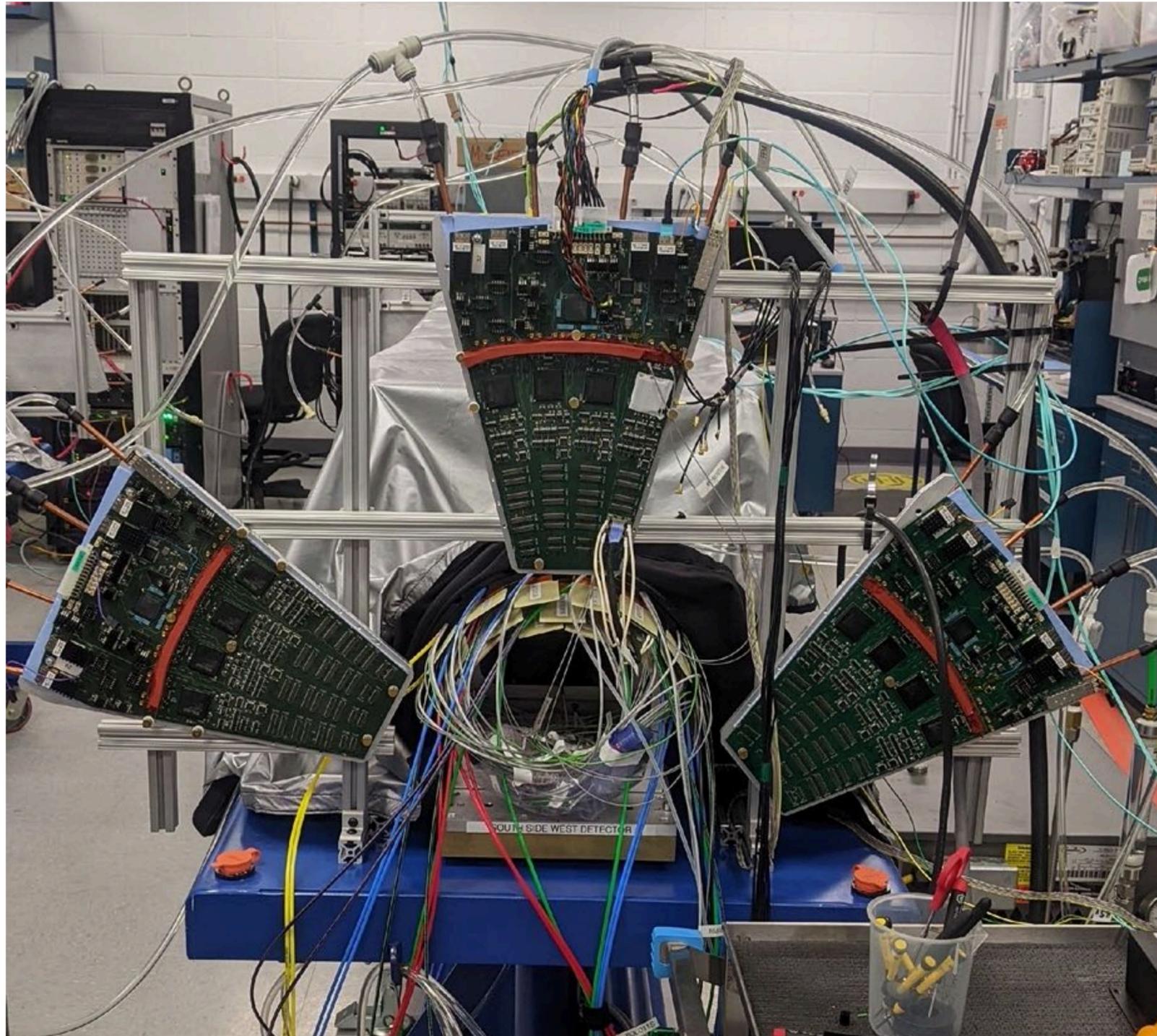
Maki Wakata
(Rikkyo Univ.)

Wei-Che Tang
(NCU)



The new HV&LV system

The 3rd test

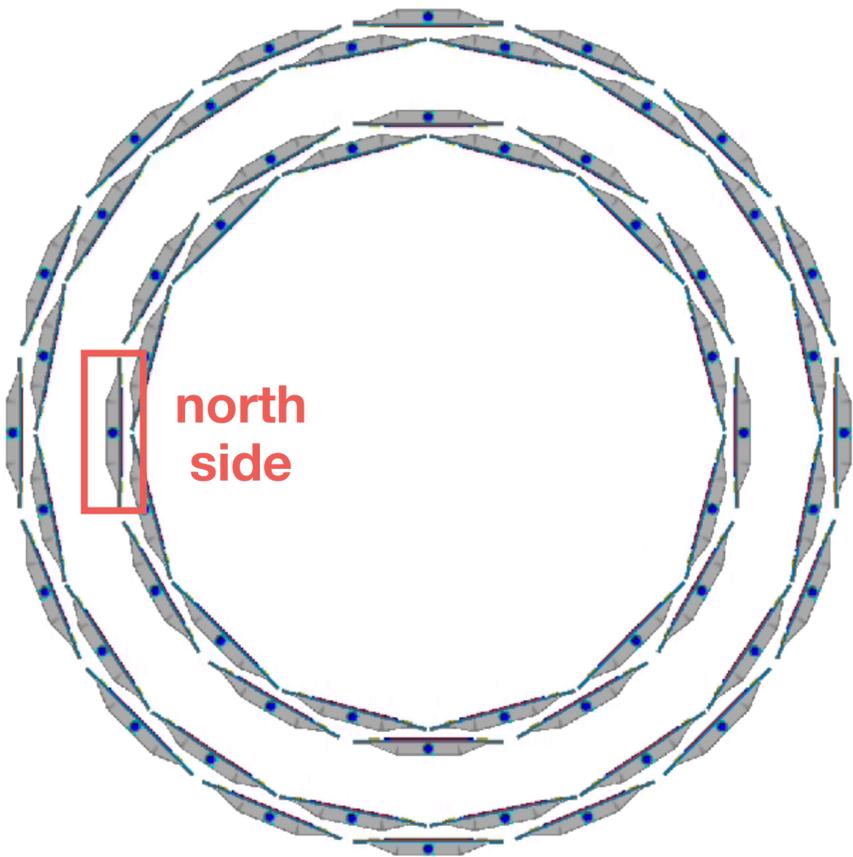


new ROC power cable

new FPHX power cable

new bias cables

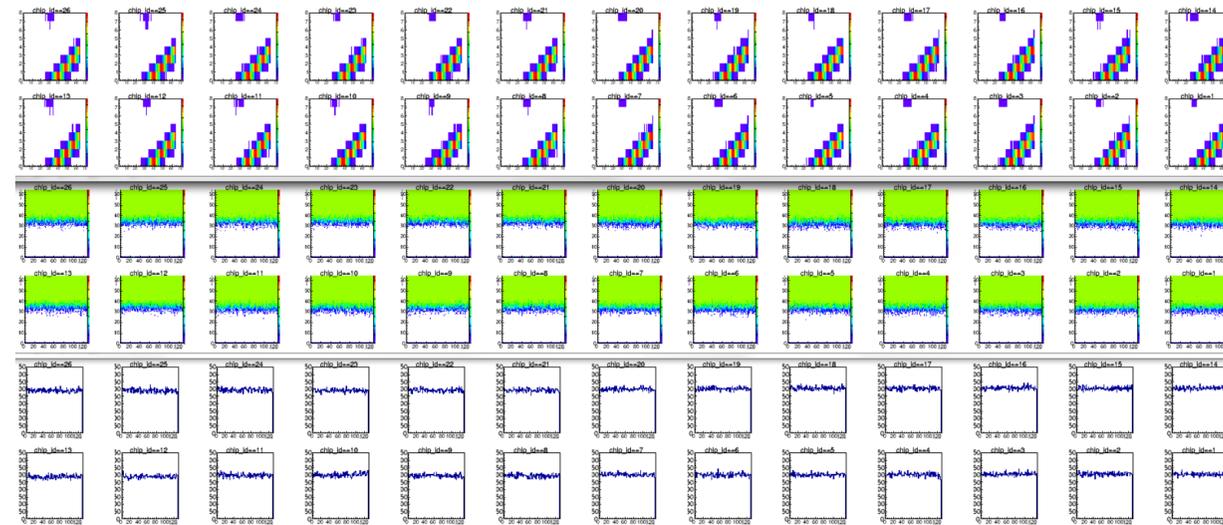
Results: Good news from 3rd test



The noise in the 2nd test is not in the 3rd test. It's as good as the one on the test bench.

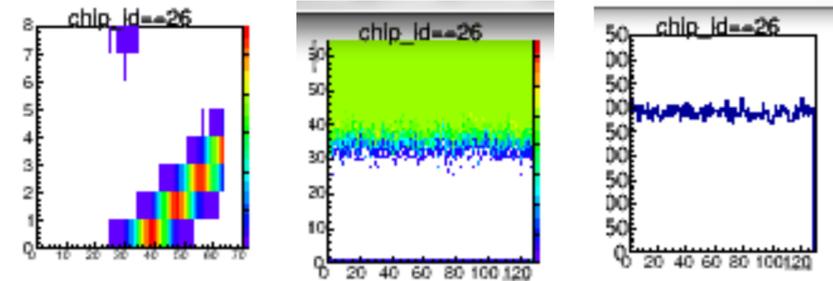
B0L109N (PB1-L023)

Test bench



Data: 20220506_1747

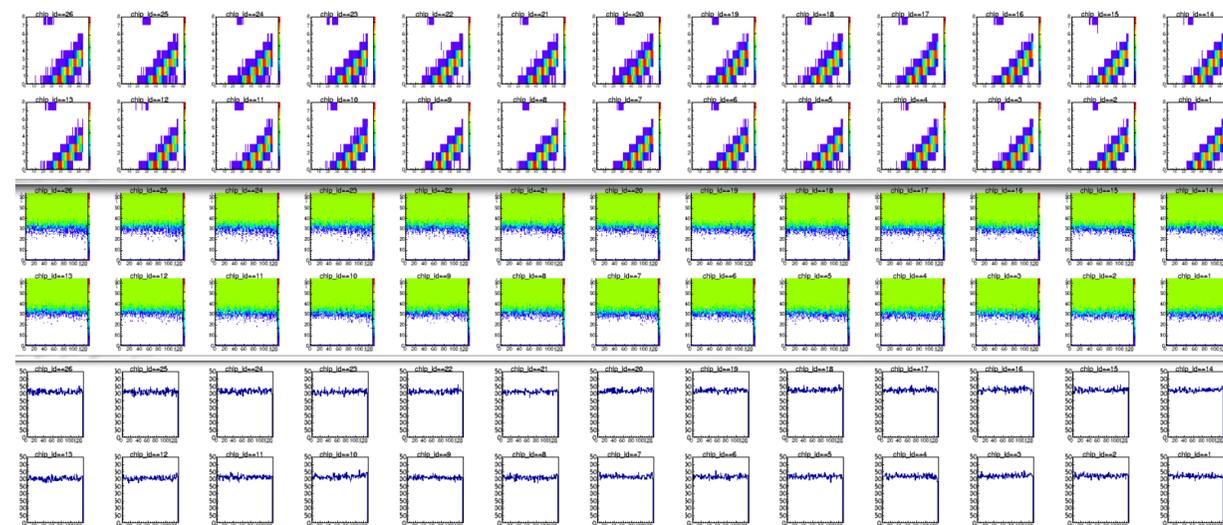
Chip26



Bias current

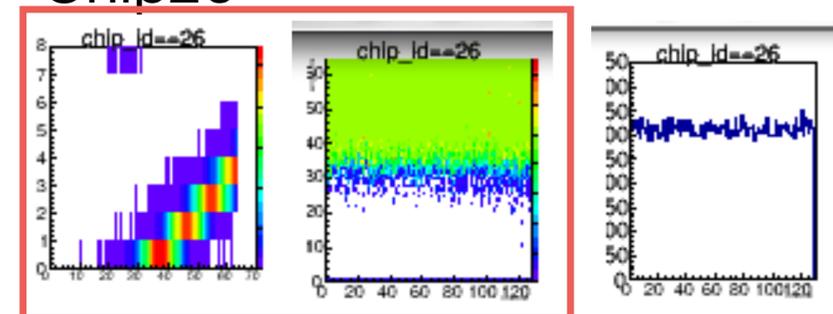
type-A: 204 nA
type-B: 105 nA

Barrel
the 2nd test



Data: 20220621_1316

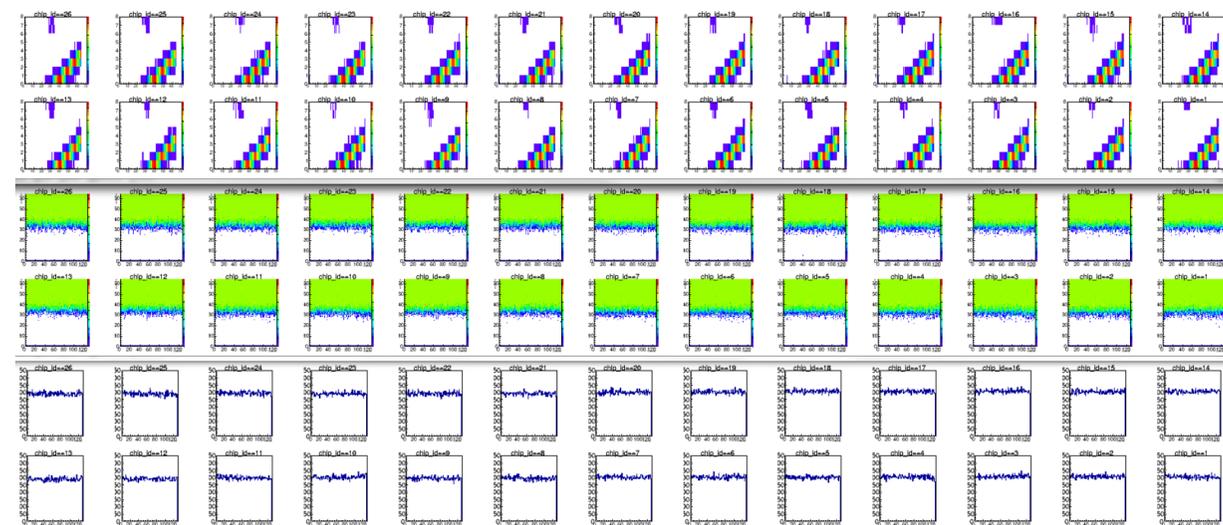
Chip26



Bias current

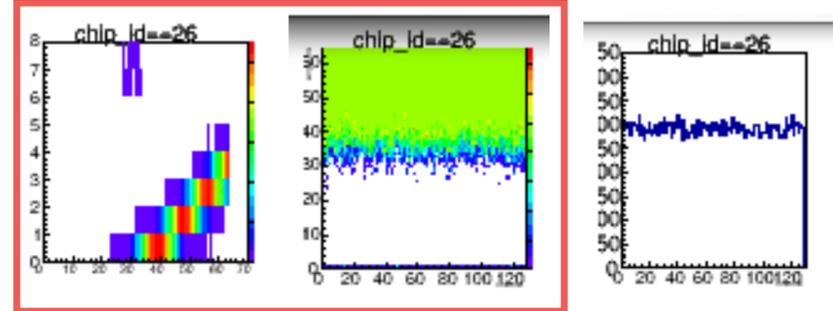
type-A: 143 nA
type-B: 87 nA

Barrel
the 3rd test



Data: 20220811_1137

Chip26



Bias current

type-A: 262 nA
type-B: 291 nA

The 3rd test: Current situation and prospect

3rd test is ongoing now, mainly by M. Hata and M. Watanabe.
 For the moment, all tested ladders showed very good results like in the test bench.

In the best cases, testing 1 half-ladder takes ~10 min. If we test all ladders, there are $2 \times (12 + 12 + 18) = 84$ ladders, it takes about 14 hours.

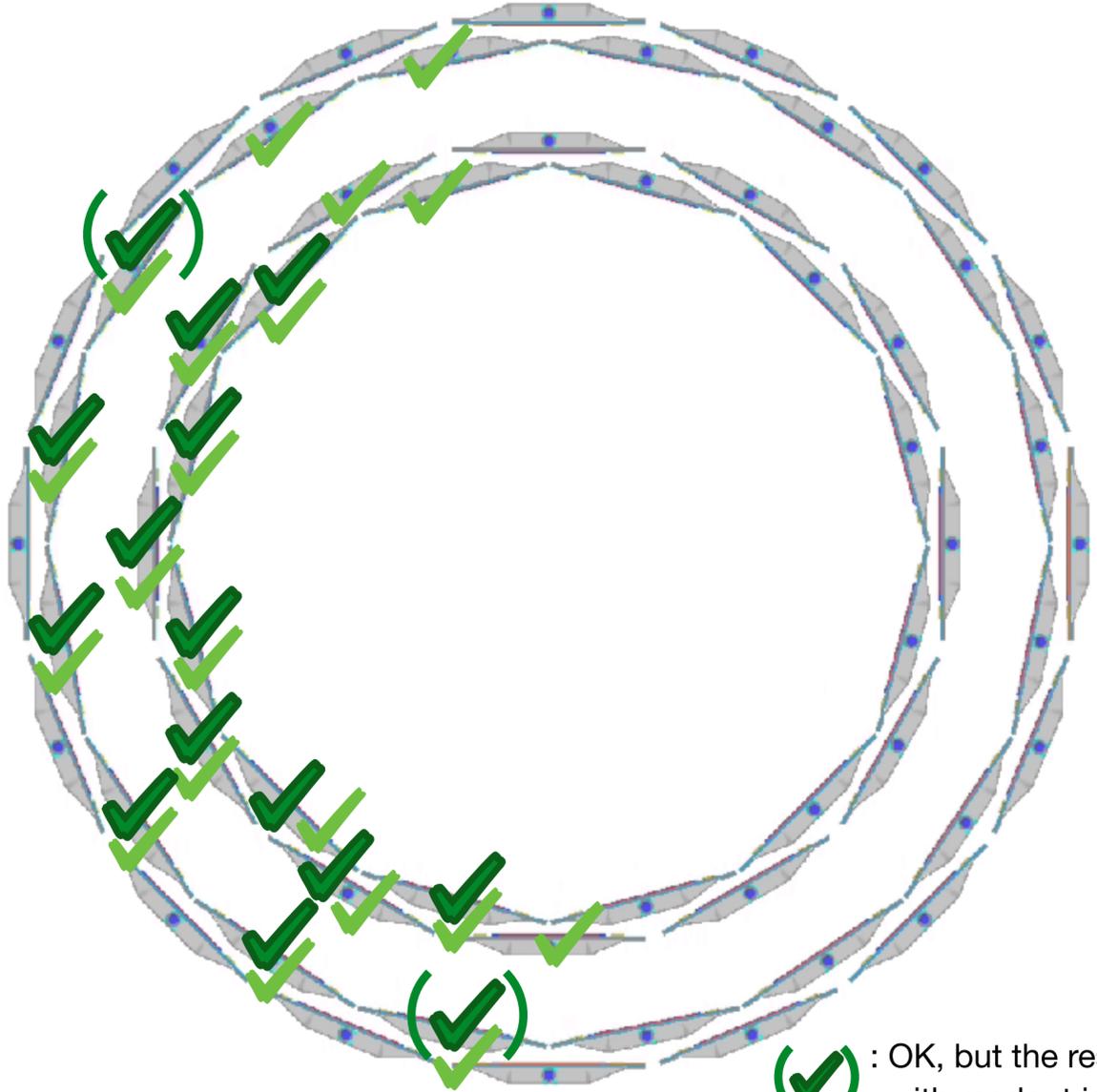
20 min/half-ladder is in average. → 28 hours
 Maybe 6 working days are enough.

Once the 2nd Felix operation system is available for these tests, we will migrate from the FEM/FEM-IB system to the new one.

North	South	
✓	✓	Tested, very good
✓	✓	Tested, slightly noisy
✓	✓	Tested, noisy



M. Watanabe (NWU) M. Hata (NWU)



(✓) : OK, but the results are with readout issues

Summary

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